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Role of 4-*tert*-Butylpyridine as a Hole Transport Layer Morphological Controller in Perovskite Solar Cells

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focused ion beam, Fourier transform infrared spectroscopy, atom probe tomography

Abstract

Hybrid organic-inorganic materials for high efficiency, low cost photovoltaic devices have seen rapid progress since the introduction of lead based perovskites and solid-state hole transport layers. Although majority of the materials used for perovskite solar cells (PSC) are introduced from dye-sensitized solar cells (DSSCs), the presence of a perovskite capping layer as opposed to a single dye molecule (in DSSCs) changes the interactions between the various layers in perovskite solar cells. 4-tert-butylpyridine (tBP), commonly used in PSCs, is assumed to function as a charge recombination inhibitor, similar to DSSCs. However, the presence of a perovskite capping layer calls for a re-evaluation of its function in PSCs. Using TEM (transmission electron microscopy), we first confirm the role of tBP as a HTL morphology controller in PSCs. Our observations suggest that tBP significantly improves the uniformity of the HTL and avoids accumulation of Li salt. We also study degradation pathways by using FTIR (Fourier transform infrared spectroscopy) and APT (atom probe tomography) to investigate and visualize in 3-dimensions the moisture content associated with the Li salt. Long term effects, over 1000 hours, due to evaporation of tBP have also been studied. Based on our findings, a PSC failure mechanism associated with the morphological change of the HTL is proposed. tBP, the morphology controller in HTL, plays a key role in this process and thus this study highlights the need for additive materials with higher boiling points for consistent long term performance of PSCs.

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As an emerging photovoltaic technology with significant potential for commercialization, hybrid organic-inorganic perovskite solar cells (PSCs) have developed rapidly in recent years.¹⁻⁴ With a certified 22.1% power conversion efficiency,⁵ compatibility with flexible substrates,^{6,7} and low fabrication energy consumption,⁸⁻¹⁰ PSCs are attracting enormous interest in both the academic and industrial field. As a p-i-n junction solar cell, a typical PSC has multiple layers and interfaces.^{11,12} Understanding the function of these components in PSCs can facilitate improvements in device efficiency and stability.¹³ Currently, a large number of researchers are focused on understanding the working mechanisms of the perovskite intrinsic layer and electron transport layer.^{11,14-16} However, investigations into the role of additives in the hole transport layer (HTL) remain relatively limited.¹⁷⁻¹⁹

Traditionally, the HTL for PSCs consists of 2,2',7,7'-tetrakis(N,N-di-p-methoxyphenylamine)-9,9'-spirobifluorene (Spiro-OMeTAD), bis(trifluoromethane)sulfonimide lithium salt (LiTFSI) and 4-tert-Butylpyridine (tBP) (For molecular structures of the HTL components see Supporting Information, Figure S1.).² This combination was first applied in solid state dye-sensitized solar cells (ss-DSSC).^{20,21} In ss-DSSC, Spiro-OMeTAD is the hole transport material, LiTFSI is the p-dopant, and tBP is the additive that acts as a recombination blocking agent.^{20,22} The function of tBP in ss-DSSC is the same as in liquid-based DSSC: tBP can adsorb on the surface of mesoporous TiO₂, which is the photoanode for DSSC. The adsorption of tBP on TiO₂: (1) suppresses direct contact between TiO₂ and electrolytes/hole transport materials to reduce charge recombination; and (2) negatively shifts the TiO₂

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3 conduction band to increase the V_{oc} of DSSC.^{23,24} Due to the similarity in the device
4 architecture for ss-DSSC and PSC, tBP is assumed to fulfill the same role in PSCs as
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6 in liquid based DSSC or ss-DSSC.^{22,25,26}
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10 However, in DSSC, dyes are discrete organic molecules which are difficult to
11
12 organize into a continuous layer, whereas in PSCs, the intrinsic perovskite layer
13 penetrates into the pores of the TiO_2 layer and also tops it as a capping layer. This
14
15 suppresses the possibility of direct contact between tBP and TiO_2 . Moreover, in ss-
16
17 DSSC, LiTFSI triggers the oxidation of Spiro-OMeTAD.^{27,28} In PSCs, despite the
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19 LiTFSI trigger, the oxidation reaction can only proceed if the perovskite layer also
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21 contributes to this process in a certain spectral range ($>450nm$).²⁹ The combined effect
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23 of the perovskite capping layer and the spectral dependence of the oxidation reaction,
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25 would allow new interactions among the components in HTL (specifically tBP) and
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27 between the HTL and intrinsic perovskite layer. This calls for a re-evaluation of the
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29 role of tBP as a charge recombination inhibitor and investigations into new
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31 interactions between the perovskite capping layer and tBP. Such detailed studies will
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33 ultimately help researchers clearly understand how PSCs works, and provide effective
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35 solutions to the stability issue ensuring better success of this technology towards
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37 commercialization.
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46 Recent reports have observed pin-holes in the HTL of PSCs.³⁰ These are considered
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48 to contribute to the poor stability of PSCs; oxygen and moisture in ambient
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50 environment can permeate through these pin-holes and cause degradation of the
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52 perovskite intrinsic layer, but the reason for the generation of pin-holes in HTL is still
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54 unclear.³¹
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3 In this work, tBP is found to function as a morphology controller in the HTL of PSCs.
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5 Our observations suggest that, tBP reduces phase separation in the stock solution prior
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7 to spin-coating. This effect improves the film quality of the HTL by decreasing
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9 inhomogeneous regions. Using Scanning Electron Microscopy (SEM) we prove that
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11 the presence of tBP significantly influences the HTL surface, by reducing the number
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13 of 'pits' (also reported as pinholes^{30,31}). On the other hand, high resolution cross-
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15 section Transmission Electron Microscopy (TEM) images show that the HTL
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17 undergoes morphological changes after long term (>1000 hours) storage of PSC. With
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19 the help of Atom Probe Tomography (APT), 3D visualization of the water distribution
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21 at HTL/perovskite interface is possible. By combining the phenomena we observe in
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23 TEM and APT, a PSC failure process mechanism is proposed, along with the
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25 morphological change of the HTL due to the evaporation of tBP. Our results indicate
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27 that tBP not only fulfills its function as previously reported for ss-DSSC, but also acts
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29 as a morphology controller directly affecting device stability.
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38 *HTL Infiltration Behavior in PSCs:* Majority of our samples in this study, are
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40 prepared by focused ion beam (FIB) which were utilized for high quality Scanning
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42 Electron Microscopy (SEM) and TEM imaging³²⁻³⁵. The FIB milling/polishing
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44 process ensured that the sample had a smooth surface. Furthermore, using a FIB-
45
46 based milling process allowed the sample to be thinned to 100 nm required for TEM
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48 characterization. As shown in Figure 1(A), the morphological contrast for every layer
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50 in PSC is distinguishable in BF-TEM. Based on FIB-prepared PSC samples for cross-
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52 section TEM imaging, we progress towards understanding the infiltration extent of
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3 HTL in PSCs. In ss-DSSC, the pore filling percentage of the HTL in a mesoporous
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5 TiO₂ photoanode is around 60% - 85% (the thickness of mesoporous TiO₂ is
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7 ~2.8 μm).^{36,37} These reports also demonstrate that reducing mesoporous TiO₂ layer
8
9 thickness can increase the pore filling percentage. In mesoporous TiO₂-based PSCs,
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11 the optimized thickness of mesoporous TiO₂ is around 300 - 400 nm.² If the HTL
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13 infiltrates into mesoporous TiO₂ to the same extent as it does in ss-DSSCs, the pore
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15 filling percentage in PSCs should be higher than 60 - 85% because of the thinner TiO₂.
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17 However, our observations show that the pore filling percentage of the HTL in TiO₂ is
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19 much lower than 60% due to the presence of the perovskite layer that has infiltrated
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21 the mesoporous TiO₂ layer.
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27 In PSC, the majority of the TiO₂ surface is covered with a perovskite capping layer,
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29 although some regions have poor coverage. Here, three components cross-section
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31 Energy Filtered TEM (EF-TEM) mapping is applied to display the infiltration
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33 behavior of HTL under the competing effect of the perovskite infiltration in
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35 mesoporous TiO₂. Two PSC samples were prepared by FIB for EF-TEM, one with
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37 poor perovskite capping layer coverage on top of the mesoporous TiO₂, the other one
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39 with rich perovskite capping layer coverage. As shown in Figure 1(B), even in
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41 perovskite poor coverage regions, the infiltration of the HTL into mesoporous TiO₂ is
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43 limited. Most of the pores within the TiO₂ layer are filled with perovskite instead of
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45 HTL (Figure 1 (B) green regions). In TiO₂ with pores deeper than 150 nm from the
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47 surface, no HTL is observed. However, when the perovskite coverage is better, as
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49 shown in Figure 1(C), the area of TiO₂ infiltrated by the HTL is even smaller. The
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51 EF-TEM mapping indicated that under the competition of the perovskite, the
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3 infiltration of the HTL to mesoporous TiO₂ is limited. The more perovskite capping
4 layer cover on top of TiO₂ the less the HTL can infiltrate into the mesoporous TiO₂.
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8 In previous reports, a penetration depth of ~ 100 nm for the HTL is observed, which
9 show strong agreement with our experimental observations.³⁴ Since then, several
10 groups have adopted superior fabrication procedures. A denser perovskite capping
11 layer can further limit the pore-filling of the HTL in TiO₂. Moreover, in planar
12 heterojunction PSCs, which are devoid of mesoporous TiO₂, the TiO₂/HTL interface
13 is further reduced. However, tBP is still used in majority of PSCs architectures and
14 device configurations. Hence, it should function differently in PSCs than in DSSCs.
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27 *tBP HTL Morphology Control Effect:* Due to the limited penetration depth and low
28 pore filling percentage, the TiO₂/HTL interface in PSCs is much smaller than in ss-
29 DSSCs. As a result, tBP acts only minimally to prevent direct contact between Spiro-
30 OMeTAD and TiO₂. However, as we observe, tBP does control the morphology of the
31 HTL.
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38 Before adding tBP, as shown in Figure 2(A), the HTL solution used for spin-coating
39 is phase separated: the LiTFSI/acetonitrile solution (acetonitrile is the solvent to
40 dissolve LiTFSI before adding to Spiro-OMeTAD solution) is immiscible with the
41 Spiro-OMeTAD/chlorobenzene solution (chlorobenzene is the solvent for spin-
42 coating of HTL). Majority of the LiTFSI/acetonitrile solution tends to accumulate at
43 the bottom of the Spiro-OMeTAD/chlorobenzene solution as small liquid droplets.
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It is possible that some complexes are formed by tBP and LiTFSI to reduce the phase separation in HTL solution and further influence the morphology of the HTL after spin-coating.

Because the existence of tBP guarantees the uniformity of HTL solution, as a result, it can affect the morphology of the spin-coated films. Several freshly prepared HTL samples were characterized by SEM/TEM as shown in Figure 2(C) to 2(H). In Figure 2(C), a top-view SEM image show that pits form on the surface of the HTL in the absence of tBP. After adding tBP, as Figure 2(D) displays, both the size and number of the pits are significantly reduced. The homogeneous nature of the solution facilitates formation of a uniform film with a limited number of pits.

In order to prove that these pits in the HTL are indeed formed due to a lack of tBP, overnight vacuum treatment (10^{-4} Pa) was applied to a HTL with tBP. It is reported that tBP evaporates under vacuum environment and no XPS signals are observed related to tBP elements.³⁰ As shown in Figure 2(E), the number and the size of the pits on the surface of the HTL increase after overnight vacuum treatment. The morphological change from Figure 2(D) to 2(E) can be attributed to the evaporation of tBP. Its disappearance/reduction causes the HTL film to revert back to an inhomogeneous state, thereby resulting in the reappearance of more pits. Moreover, a few pits are located in the HTL even with tBP (Figure 2(D)), which we ascribe to the volatile nature of tBP on the surface. tBP can partially evaporate at the surface of the HTL, allowing a small portion of LiTFSI to regather and form pits.

To further study the morphological control of tBP on the HTL, FIB was used to prepare cross-section HTL samples with and without tBP. This enabled us to observe

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3 the morphology of the bulk of the film via BF-TEM at high resolution. Figures 2(F) to
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5 Figure 2(H) are BF-TEM images of the HTL cross-section without tBP, with tBP and
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7 with tBP after over night treatment, respectively. In Figure 2(F), without tBP, the
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9 HTL has an inhomogeneous morphology. Several bubble-like structures appear in the
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11 HTL. When the HTL contains tBP, as shown in Figure 2(G), the bulk of the film is
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13 homogeneous. After overnight vacuum treatment of the tBP-contained film, Figure 2
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15 (H), inhomogeneous regions appear again. For the various treatment histories, the
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17 morphology of the inhomogeneous regions in the tBP-free sample and that of the
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19 vacuum treatment tBP sample are slightly different, but the size and the distribution of
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21 the inhomogeneous regions for these two samples are in the same range.
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27 In addition, we also characterized the tBP-contained film after thermal annealing.
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29 200 °C was selected as the heat treatment temperature, as this temperature is above the
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31 boiling point of tBP and below the melting points for LiTFSI and Spiro-OMeTAD.
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33 The morphology of the top view (Supporting Information, Figure S2(A)) and the
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35 cross-section view (Supporting Information, Figure S2(B)) of the thermal annealing
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37 film is characterized. In Figure S2(A), the number and size of the pits on the surface
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39 of the HTL increase after heat treatment. However, the morphology and location of
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41 the inhomogeneous regions in cross-section image of the annealed tBP sample is
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43 different compare with the vacuum treatment sample and the tBP-free sample. The
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45 inhomogeneous regions of the tBP-free and vacuum treatment samples show more
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47 small bubble-like regions that are mainly located at bulk of the film. These
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49 inhomogeneous regions show brighter contrast compared with the rest of the film.
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51 While in Figure S2(B), the annealed sample's inhomogeneous regions are on top of
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3 the film, they show darker contrast compared with the rest of the film. These
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5 differences can be attributed to the melting of LiTFSI on 200 °C homogenizes bulk of
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7 the thermal annealing film, however, it still can not prevent the surface morphological
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9 change due to the evaporation of tBP. In conjunction with the top view SEM and
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11 cross-section TEM results (Figure 2(C) to Figure 2(H), Supporting Information Figure
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13 S2(A) and Figure S2(B)), it is obvious that tBP can affect both the surface and bulk
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15 morphology of HTL.
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22 Previous reports described the non-uniform structure of the HTL as ‘pinholes’: the
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24 authors proposed that the pinholes pass through the entire HTL layer, which put
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26 moisture and air in direct contact with the surface of perovskite layer and trigger
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28 further degradation.^{30,31} If pinholes did indeed exist in the HTL, a cross-section TEM
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30 image of a PSC would reveal this specific morphology. However, the cross-section
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32 TEM images (Figures 1 and 2) prove that the HTL is uniform (in presence of tBP). In
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34 Supporting Information Figure S3, a cross-section BF-TEM image of a PSC showing
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36 a larger region for the HTL also indicates that the bulk of the HTL is homogeneous
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38 and contains no pinholes. On the other hand, the metal (top electrode)/HTL interface
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40 is not flat, which suggests that the surface morphology has shallow pits instead of
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42 pinholes (Supporting Information, Figure S4). To demonstrate the difference between
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44 a ‘pit’ and ‘pinhole’ in the HTL, a picture is shown in Supporting Information Figure
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46 S5: although the morphology of the HTL looks similar from a top view, in the cross-
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48 section the ‘pinholes’ and ‘pits’ are easy to distinguish. To get the accurate
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50 morphological information of HTL and to prevent the FIB process from damaging the
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3 sample, two measures were taken into our experiment: (1) Before FIB process, all
4 samples were pre-deposited with a metal protecting layer (Pt or Ir 200 nm and then
5 2um Pt), which can prevent the beam from damaging the top of the HTL. (2) During
6 FIB thinning process, only 5kV voltage and 7pA current were applied to the sample
7 when the sample thickness is smaller than 200 nm. This measure can minimize the
8 beam-induced damage to only 10 nm.³⁸
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20 *HTL morphological change in PSCs:* Apart from our observation of pits on the
21 surface of the HTL (in the absence of tBP), its effect on the stability still needed
22 further investigation. Since the evaporation of tBP can also lead to morphological
23 change of the HTL as mentioned earlier, we suspect this effect exists in a real device
24 and finally influences the device performance. To study this mechanism, we observe
25 the long-term morphological change of the HTL in an unsealed full PSC. We store the
26 PSC samples under ambient dark conditions with 10% moisture for 1000 hours. Four
27 samples for BF-TEM were prepared by FIB on the same cell after different storage
28 time (0, 200, 500, and 1000 hours).
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40 As shown in Figure 1 (A), at the start, the HTL is homogeneous. As discussed before,
41 that is because tBP promotes miscibility of LiTFSI and Spiro-OMeTAD. After 200
42 hours, as Figure 3(A) displays, inhomogeneous dark regions appear on the HTL.
43 These regions are due to the accumulation of Li salt which occurs due to the loss of
44 tBP by evaporation. Figure 3(B) shows the morphology of the HTL after 500 hours.
45 The majority of the dark regions disappear, even as bubble-like structures are
46 generated. This likely occurs because of the hygroscopicity of LiTFSI: moisture can
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3 easily react with the accumulated LiTFSI seen in Figure 3(A). The hydration of
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6 LiTFSI therefore leads to the bubble structures in the HTL. Finally, in Figure 3(C),
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8 after 1000 hours, the perovskite has decomposed. These images display that the
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10 morphological change, in other words, the failure process of PSCs, is initiated from
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12 the HTL instead of the perovskite layer followed by eventual degradation of
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14 perovskite. The related photo current density-voltage curves (J-V curves) and device
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16 parameters for the stored cells are shown in Figure 3(D) and Table 1. Compare with
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18 the freshly prepared PSCs (12.6%), the performance decay of the 250 hours (10.9%)
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20 and 500 hours (7.51%) PSCs are not as obviously as the 1000 hours PSCs. It is
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22 consistent with the TEM results since the decomposition of the perovskite layer at the
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24 first 500 hours is limited while at 1000 hours, perovskite layer has decomposed.
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32 Based on the morphology control effect of tBP on HTL and the failure process of the
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34 PSCs, a mechanism regarding the long-term morphological change in a perovskite
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36 solar cell is presented now. As displayed in Figure 4, at the start (right after device
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38 fabrication), the existence of tBP guarantees a uniform HTL, with minimal shallow
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40 pits located on the surface the of the HTL. After tBP evaporates, the Li salt
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42 accumulates, shown as dark circular regions. These regions are further hydrated to
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44 create void structures in the HTL which finally lead to decomposition of the
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46 perovskite layer. It should be noted that these events may not strictly proceed one
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48 after the other, but may instead occur at the same time. During the LiTFSI hydration
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50 process, for instance, the decomposition of the perovskite may have already begun
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52 since water is already in the HTL.
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6 *Humidity Accumulation Characterizations in PSCs:* To further confirm that the lack
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8 of tBP can lead to the increasing amount of water in HTL, four fresh-prepared Spiro-
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10 OMeTAD films with various components combinations were characterized by Fourier
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12 transform infrared spectroscopy (FTIR). As shown in Figure 5, films of pure Spiro-
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14 OMeTAD (black line), Spiro-OMeTAD/tBP (red line), and Spiro-
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16 OMeTAD/tBP/LiTFSI (dark green line) all display similar peaks. That is because the
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18 primary component of the HTL film is Spiro-OMeTAD (in accordance with the
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20 weight percentage of the HTL spin-coating solution). However, a water peak is
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22 observed in the Spiro-OMeTAD/LiTFSI sample (blue line). This broad peak at ~ 3600
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24 cm^{-1} corresponds to the O-H stretching mode of water in FTIR. In contrast, no water
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26 peak appears in the Spiro-OMeTAD/ tBP/LiTFSI sample (dark green line). This
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28 indicates that tBP prevents the accumulation of LiTFSI in Spiro-OMeTAD films,
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30 thereby reducing the possibility of LiTFSI hydration since the material is well
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32 dispersed throughout the Spiro-OMeTAD and shielded by tBP. The mechanism of
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34 how tBP prevents LiTFSI hydration at a chemical level will be the scope of our future
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36 work.
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46 The FTIR study confirmed the presence of moisture in films without tBP, but in order
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48 to visualize that moisture truly exists in the HTL for a full cell device structure, we
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50 utilized laser-assisted atom probe tomography (APT). With the unique ability of APT
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52 to obtain three dimensional (3D) position information and compositional mapping of
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54 energy materials,^{39,40} we constructed a map of the water accumulated in PSCs at the
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3 HTL/ perovskite interface. The PSC devices were stored for over 500 hours prior to
4 sample preparation for APT analysis. This corresponds to the morphology of Figure
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8 3(B). In this state, as mentioned before, tBP would evaporate allowing the
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10 accumulation of LiTFSI and its possible hydration.

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12 Figure 6(A) displays a perovskite solar cell cross section wedge lifted out for
13 preparing an atom probe needle specimen. Various layers in the device architecture
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16 are clearly visible. The annular milling process during final stages of the needle
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18 specimen preparation was controlled to retain the HTL layer on the specimen apex
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20 and then proceed to the perovskite layer below, with the interface in between. In
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22 Figure 6(B), the APT maps show the clear boundary between F (red) and Pb (blue),
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24 corresponding to the perovskite/HTL interface. Pb and F maps are used since they are
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26 the sole indicators for perovskite and LiTFSI respectively, not present in any other
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28 layers. Although fluorine signatures can be obtained from the FTO (fluorine doped tin
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30 oxide) layer, atomic positions of F above the Pb region do not conform to the position
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32 of the FTO layer. Another caveat is the low analysis temperature used for APT
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34 analysis (60 K) which is below the phase transition temperature for the intrinsic
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36 perovskite layer. We do not expect that the phase transition would affect the ordering
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38 of the layers and the interfaces.

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40 As shown in Figure 6(C), the chemical map for water indicates a strong concentration
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42 at the specimen apex region as opposed to the entire region of analysis. To the best of
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44 our knowledge, such a strong concentration could not possibly occur from a
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46 background signal (see Supporting Information, Figure S6 for a more quantitative
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48 analysis). This region of water accumulation is concurrent with regions of high F
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3 concentration. Thus we conclude that water accumulates in the HTL rather than the
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5 perovskite layer.
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7
8 In comparison to similar chemical maps for F and H₂O, using freshly prepared
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10 samples (see Supporting Information, Figure S7 for more details) with no ageing, the
11
12 total counts for H₂O and F ions are 5 times higher. These observations are also
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14 consistent with our TEM results and FT-IR data. In PSCs samples stored in ambient
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16 under dark conditions, the amount of tBP in the HTL is reduced due to its relatively
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18 low boiling point and volatile nature. As a result, the HTL prefers to adsorb water due
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20 to the hygroscopicity of LiTFSI.
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26 In Conclusion, the function of tBP in PSCs was re-evaluated to understand its
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28 influence on device stability. Due to the limited penetration depth of HTL into
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30 mesoporous TiO₂, it is unlikely that the additive serves only to prevent contact
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32 between the Spiro-OMeTAD and TiO₂ layers as traditionally assumed. Based on our
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34 observations, tBP functions as a morphological controller for the HTL. It prevents
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36 phase separation of LiTFSI and Spiro-OMeTAD during spin-coating of the solution,
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38 resulting in a uniform HTL film. The absence of tBP leads to inhomogeneous films
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40 and also causes the appearance of large pits on the surface of the HTL. tBP-free HTL
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42 easily absorbs water due to the hygroscopicity of accumulated LiTFSI and further
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44 lowers the stability of PSCs. In PSCs stored in ambient dark conditions for 1000
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46 hours, the slow evaporation of tBP (as it is the only liquid component in PSCs), leads
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48 to all of the above discussed phenomena. Li salt accumulates and generates ‘dark
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50 regions’ in the HTL. These dark regions then turn into void bubble structures due to
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2
3 the hydration of Li salt. Finally, the water contained in the HTL contributes to
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5 perovskite degradation. Since the evaporation of tBP is a primary contributor to the
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7 poor stability of PSCs, we suggest that the performance of PSCs can be enhanced by
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9 utilizing other pyridine derivatives that can fulfill the same functions as tBP but have
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11 much higher boiling points.
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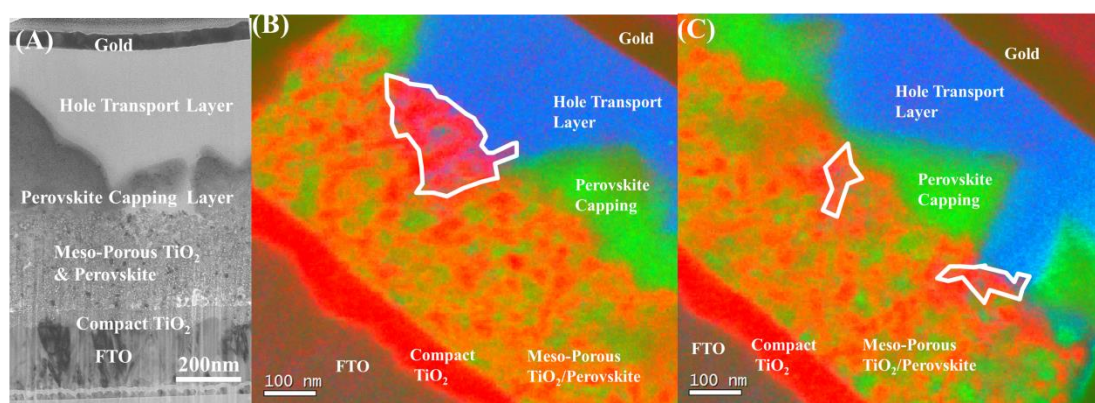


Figure 1. Correlation between perovskite coverage and HTL infiltration. (A) Bright Field TEM cross-section image of PSC prepared by focused ion beam (FIB). (B) Energy Filtered-TEM mapping of a PSC cross-section with poor perovskite coverage. (Blue indicates Spiro-OMeTAD, red TiO₂, and green perovskite. Regions where the HTL infiltrates the mesoporous TiO₂ are outlined in white.) (C) EF-TEM mapping of a PSC cross-section with rich perovskite coverage (Blue indicates Spiro-OMeTAD, red TiO₂, and green perovskite. Regions where the HTL infiltrates the mesoporous TiO₂ are outlined in white.).

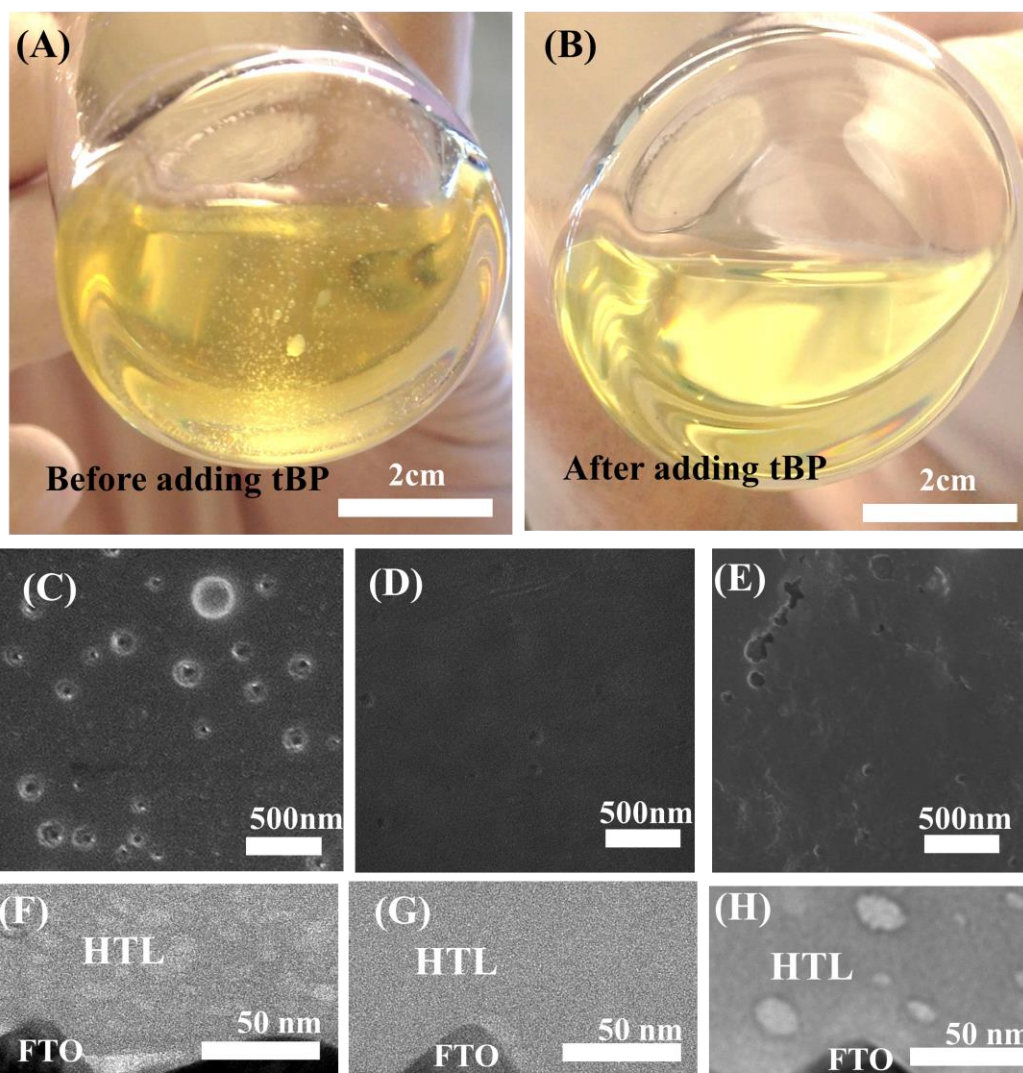


Figure 2. Photographs of HTL solution used for spin coating (A) Before adding tBP (B) After adding tBP. Top-view SEM images of the freshly prepared HTL (C) without tBP (D) with tBP, and (E) with tBP after overnight vacuum treatment (10^{-4} Pa). Cross-section BF-TEM images of the freshly prepared HTL (F) without tBP, and (G) with tBP, and (H) with tBP after overnight vacuum treatment (10^{-4} Pa).

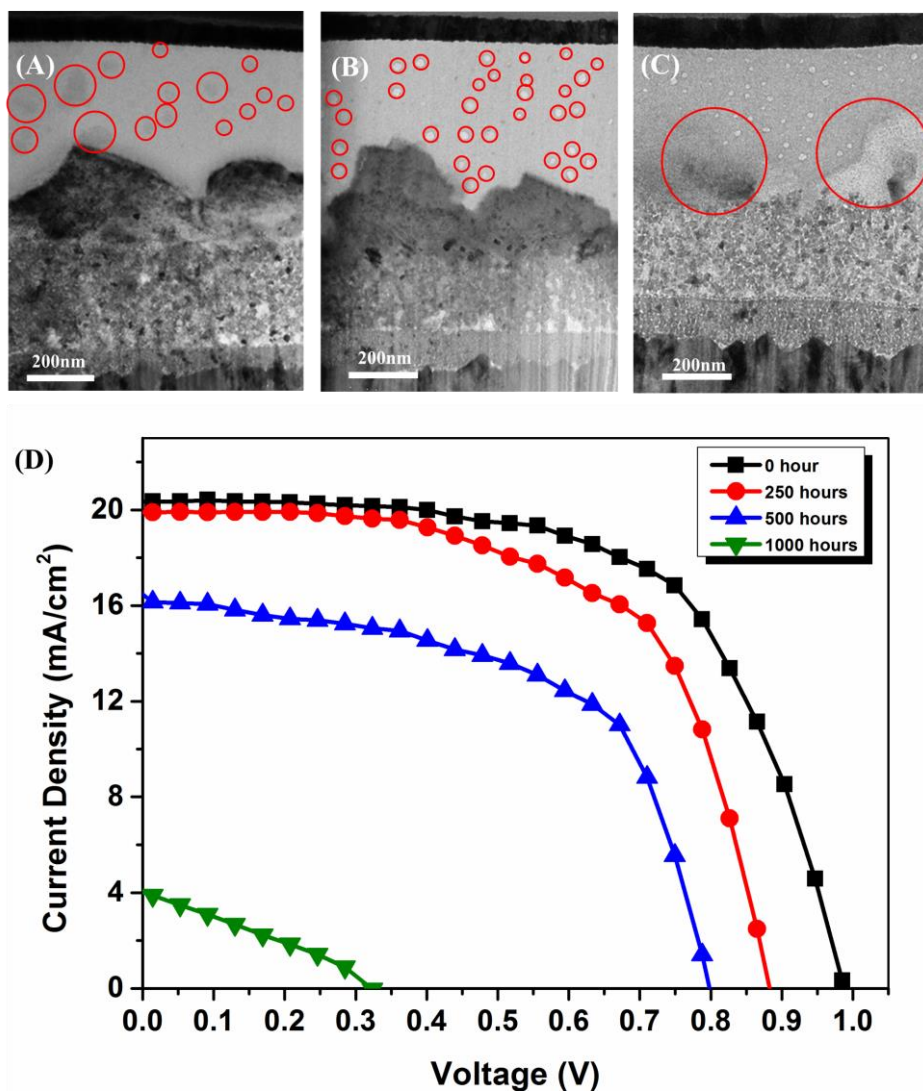


Figure 3. BF-TEM cross-section images of the long-term morphological change in the HTL after (A) 200 hours storage (inhomogeneous regions in the HTL marked with red circles), (B) 500 hours storage (bubble structures in the HTL marked with red circles), and (C) 1000 hours storage (degraded perovskite capping layer marked by red circles). (D) J-V curves of the stored perovskite solar cells. Each curve is the average of 10 cells prepared at the same batch of the TEM sample.

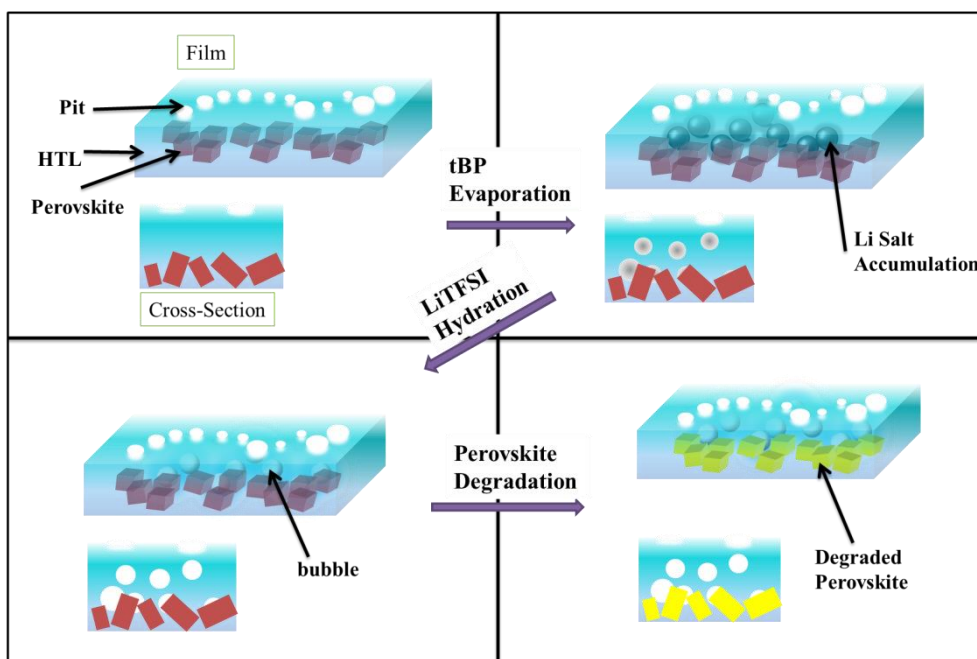


Figure 4. Schematic of the morphological change of the HTL/perovskite layers as they are stored in dark conditions.

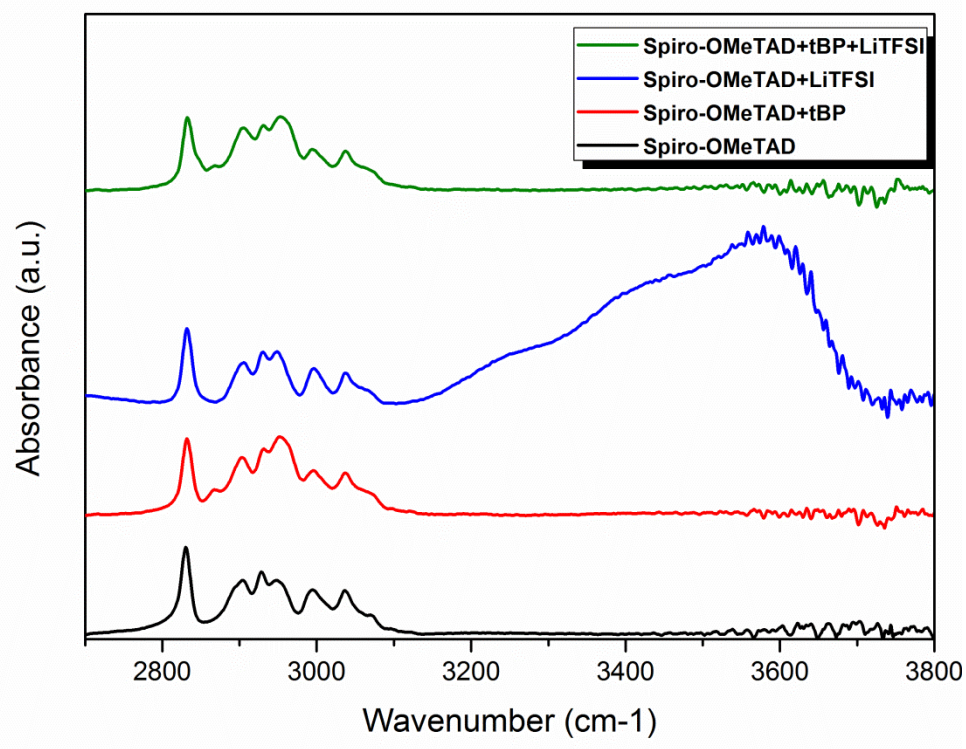


Figure 5. FTIR spectra of Spiro-OMeTAD films with various component combinations

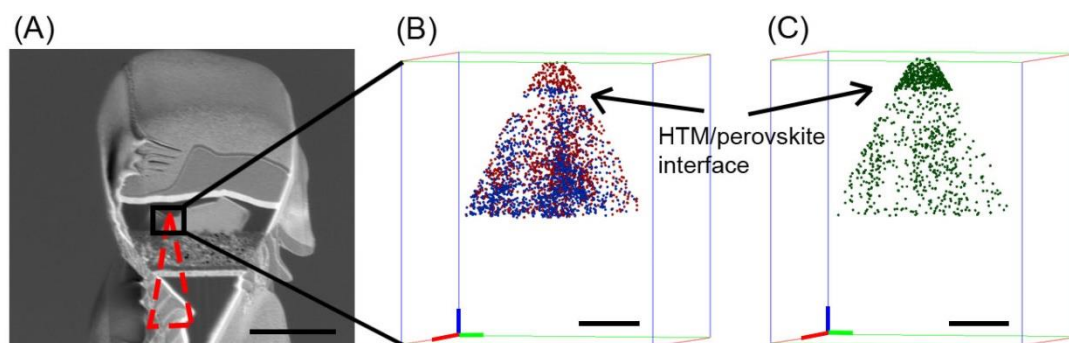


Figure 6 3D APT maps of HTL/perovskite layers after long-term storage (> 500 hours) (A) SEM image of an APT sample section attached on a Si micropost prior to annular milling by FIB. The red section shows the analysis area. (Scale bar is 1 μm). (B) 3D elemental maps of Pb (blue dots, from perovskite $\text{CH}_3\text{NH}_3\text{PbI}_3$) and F (red dots, from TFSI in HTL). (C) APT map of H_2O showing its distribution in 3D. (Scale bar in (B) and (C) are 10 nm. Shown in green is the x-axis, red corresponds to the y-axis and blue is the z-axis.)

Table 1. Cell parameters of the perovskite solar cells stored for 1000 hours at 10% humidity ambient dark condition

	V_{OC} (V)	J_{SC} (mA/cm ²)	Fill Factor	Efficiency (%)
0 hour	0.987	20.38	0.63	12.6
250 hour	0.886	19.97	0.62	10.9
500 hour	0.799	16.16	0.58	7.51
1000 hour	0.331	3.90	0.29	0.38

Associated Content

Supporting Information

The Experimental methods for this research are shown in Supporting Information.

Molecular Structures of the components in the HTL for PSCs are displayed in Supporting Information (Figure S1). More detailed FIB-TEM and APT information are included in Supporting Information as well (Figure S2 to Figure S7) This material is available free of charge via <http://pubs.acs.org>.

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The manuscript was written through contributions of all authors. All authors have given approval to the final version of the manuscript.

Notes

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19 Electron Microscopy at Lawrence Berkeley National Laboratory.
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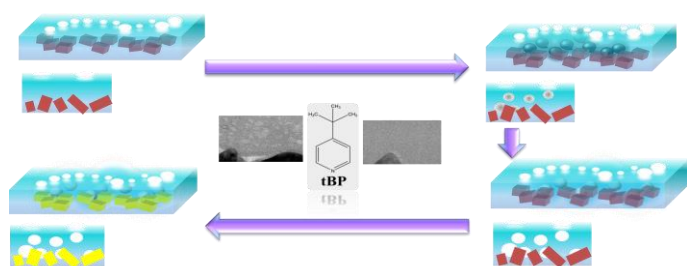
22 Sample preparation and analysis for atom probe tomography was performed using
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